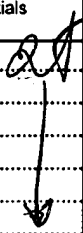
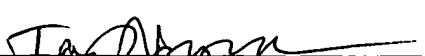


INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Complete if Known	
				Application Number	
				Filing Date	Herewith
				First Named Inventor	Hayden
				Art Unit	
Examiner Name					
Sheet	1	of	2	Attorney's Docket No.	TAL:1016.2023



U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines where passages or relevant figures appear
		Number - Kind Code (if known)			
	AA	US- 4697143	09-29-1987	Lockwood et al.	
	AB	US- 4891584	01-02-1990	Kamieniecki et al.	
	AC	US- 5506515	04-09-1996	Godshalk et al.	
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	AL	US-			
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	AO	US-			
	AP	US-			
	AQ	US-			
	AR	US-			
	AS	US-			
AT	US-				
AU	US-				

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Documents	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, columns, lines where passages or relevant figures appear	T ¹
		Country Code - Number - Kind Code				
	BA	JP-55115383-A2	09-05-1980	Mitsubishi Electric Corp.	Abstract, figures	✓
	BB	JP-57075480	05-12-1982	NEC Corp.	Abstract	✓
	BC					
	BD					
	BE					
	BF					
	BG					
	BH					
	BI					
	BJ					

Examiner Signature		Date Considered	3/17/04
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Applicant is to place a check mark here if English language translation is attached.

INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Complete If Known	
				Application Number	
				Filing Date	Herewith
				First Named Inventor	Hayden
				Art Unit	
				Examiner Name	
Sheet	2	of	2	Attorney's Docket No.	TAL:1016.2023

OTHER PRIOR ART-NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. ¹	Include name of author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and or country where published	T ²
 	CA	"Air Coplanar™ Probe Series," 2000, Cascade Microtech Inc., Beaverton, Oregon.	
	CB	"Electro-Optical Component Test," 2001, Cascade Microtech Inc., Beaverton, Oregon.	
	CC	"Laser Diode Test Solution," unknown, www.cascademicrotech.com/index.cfm/fuseaction/pg.view/pID/136 , Cascade Microtech Inc., Beaverton, Oregon.	
	CD		
	CE		
	CF		
	CH		
	CI		
	CJ		
	CK		

Examiner Signature		Date Considered	3/17/24
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² Applicant is to place a check mark here if English language translation is attached.